Notice of References Cited Application/Control No. 10/814,731 Examiner AYODEJI AYOTUNDE Applicant(s)/Patent Under Reexamination OFEK ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,198,449 B1	03-2001	Muhlhauser et al.	343/753
*	В	US-6,393,303 B1	05-2002	Katz, Marcos	455/562.1
*	С	US-2004/0224637 A1	11-2004	Silva et al.	455/063.4
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-		i = + ii	
	ı	US-	6		
	J	US-			
	K	US-	1		
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q					
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	s					
	Т				100	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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